

<b>Notice of References Cited</b>	Application/Control No. 10/781,782		Applicant(s)/Patent Under Reexamination YAMASHITA ET AL.	
	Examiner VIJAY SHANKAR		Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0024352 a1	02-2005	Sano, Keiichi	345/204
*	B	US-2005/0168602 a1	08-2005	Sumi et al.	348/294
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